

Notice of References Cited	Application/Control No. 10/766,591		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Chrystina Zelaskiewicz		Art Unit 4143	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0050114	03-2003	Leen et al.	463/25
*	B	US-6,758,754	07-2004	Lavanchy et al.	463/42
*	C	US-7,086,947	08-2006	Walker et al.	463/25
*	D	US-7,367,888	05-2008	Chen et al.	463/42
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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